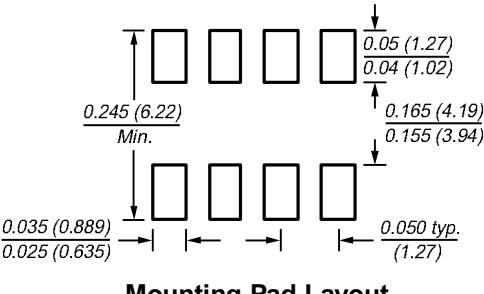
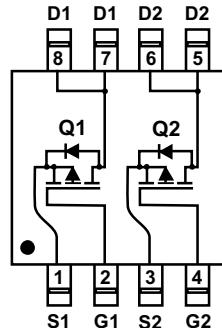
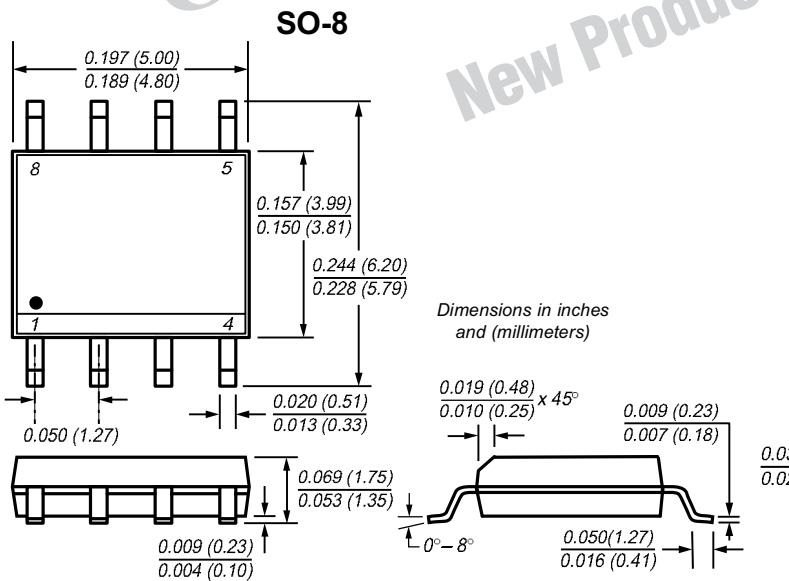




**TRENCH  
GENFET™**

## Dual P-Channel Enhancement-Mode MOSFET

V<sub>DS</sub> –30V R<sub>DS(ON)</sub> 53mΩ I<sub>D</sub> –4.9A



### Mechanical Data

**Case:** SO-8 molded plastic body

**Terminals:** Leads solderable per MIL-STD-750, Method 2026

**High temperature soldering guaranteed:**  
250°C/10 seconds at terminals

**Mounting Position:** Any

**Weight:** 0.5g

### Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

### Maximum Ratings and Thermal Characteristics (T<sub>A</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	
Continuous Drain Current (T <sub>J</sub> = 150°C)	I <sub>D</sub>	-4.9 -3.9	A
Pulsed Drain Current	I <sub>DM</sub>	-30	
Maximum Power Dissipation <sup>(1)</sup>	P <sub>D</sub>	2.0 1.3	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Maximum Junction-to-Ambient Thermal Resistance <sup>(1)</sup>	R <sub>θJA</sub>	62.5	°C/W

**Note:** (1) Surface Mounted on FR4 Board, t ≤ 10 sec.

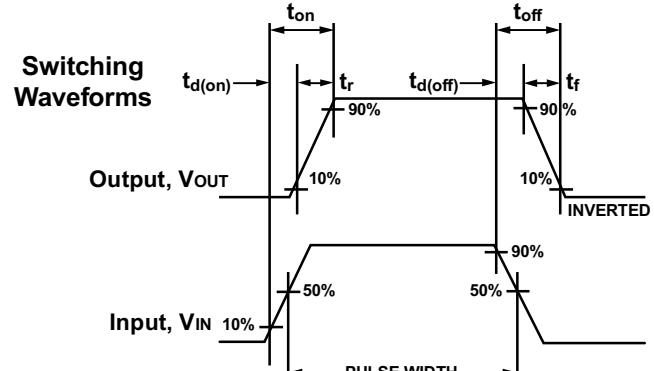
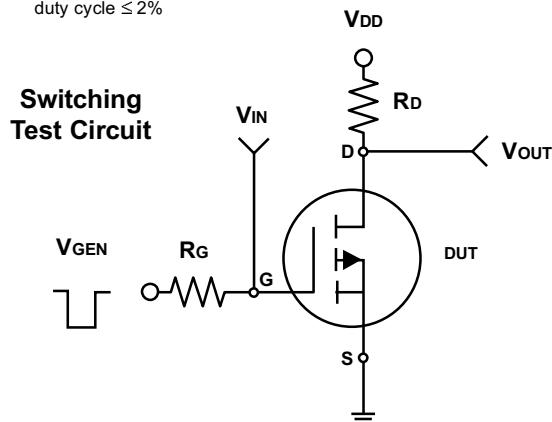
7/10/01

# Dual P-Channel Enhancement-Mode MOSFET

## Electrical Characteristics ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = -250\mu\text{A}$	-30	-	-	V
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = -250\mu\text{A}$	-1.0	-	-3.0	V
Gate-Body Leakage	$\text{I}_{\text{GSS}}$	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$\text{I}_{\text{DSS}}$	$\text{V}_{\text{DS}} = -30\text{V}, \text{V}_{\text{GS}} = 0\text{V}$	-	-	-1.0	$\mu\text{A}$
		$\text{V}_{\text{DS}} = -30\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$	-	-	-25	
On-State Drain Current <sup>(1)</sup>	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq -5\text{V}, \text{V}_{\text{GS}} = -10\text{V}$	-20	-	-	A
Drain-Source On-State Resistance <sup>(1)</sup>	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = -10\text{V}, \text{I}_D = -4.9\text{A}$	-	43	53	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = -4.5\text{V}, \text{I}_D = -3.6\text{A}$	-	65	95	
Forward Transconductance <sup>(1)</sup>	$\text{g}_{\text{fs}}$	$\text{V}_{\text{DS}} = -15\text{V}, \text{I}_D = -4.9\text{A}$	-	10	-	S
<b>Dynamic</b>						
Total Gate Charge	$\text{Q}_g$	$\text{V}_{\text{DS}} = -15\text{V}, \text{I}_D = -4.9\text{A}, \text{V}_{\text{GS}} = -5\text{V}$	-	10	14	nC
		$\text{V}_{\text{DS}} = -15\text{V}, \text{V}_{\text{GS}} = -10\text{V}$	-	18	25	
Gate-Source Charge	$\text{Q}_{\text{gs}}$	$\text{I}_D = -4.9\text{A}$	-	3.0	-	
Gate-Drain Charge	$\text{Q}_{\text{gd}}$		-	4.0	-	
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$	$\text{V}_{\text{DD}} = -15\text{V}, \text{R}_L = 15\Omega$ $\text{I}_D \approx -1\text{A}, \text{V}_{\text{GEN}} = -10\text{V}$ $\text{R}_G = 6\Omega$	-	9.0	15	ns
Rise Time	$\text{t}_r$		-	5.0	20	
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$		-	55	75	
Fall Time	$\text{t}_f$		-	18	25	
Input Capacitance	$\text{C}_{\text{iss}}$	$\text{V}_{\text{DS}} = -15\text{V}, \text{V}_{\text{GS}} = 0\text{V}$ $f = 1.0\text{MHz}$	-	860	-	pF
Output Capacitance	$\text{C}_{\text{oss}}$		-	180	-	
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$		-	120	-	
<b>Source-Drain Diode</b>						
Maximum Diode Forward Current	$\text{I}_s$	-	-	-	-1.7	A
Diode Forward Voltage	$\text{V}_{\text{SD}}$	$\text{I}_s = -1.7\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	-	0.8	-1.2	V

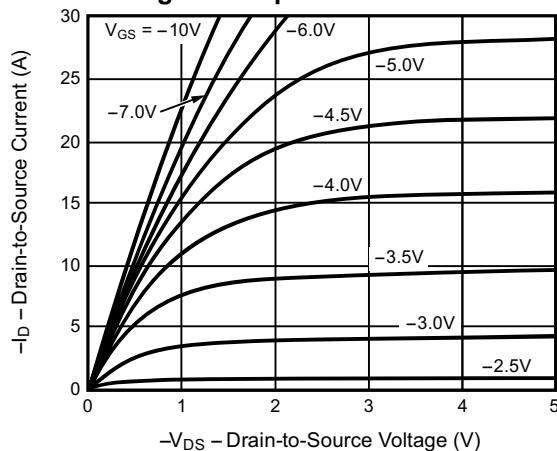
Note: (1) Pulse test; pulse width  $\leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$



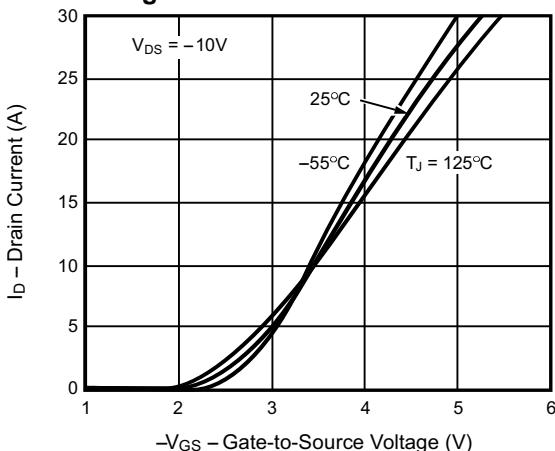
## Dual P-Channel Enhancement-Mode MOSFET

### Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

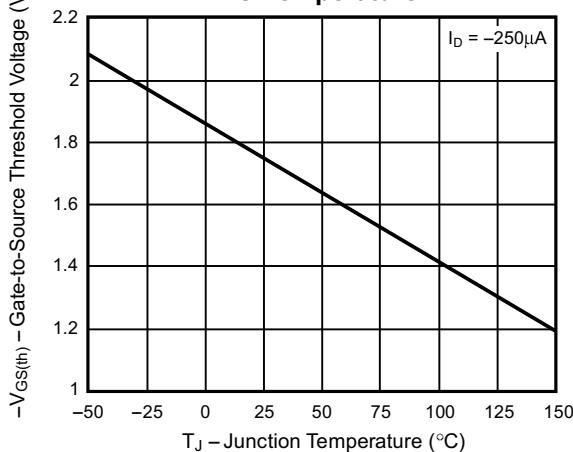
**Fig. 1 – Output Characteristics**



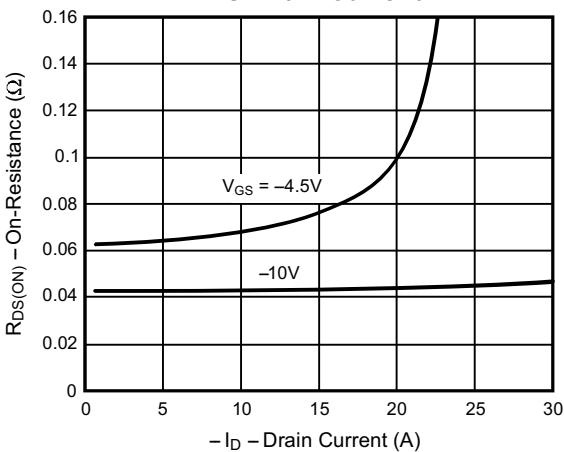
**Fig. 2 – Transfer Characteristics**



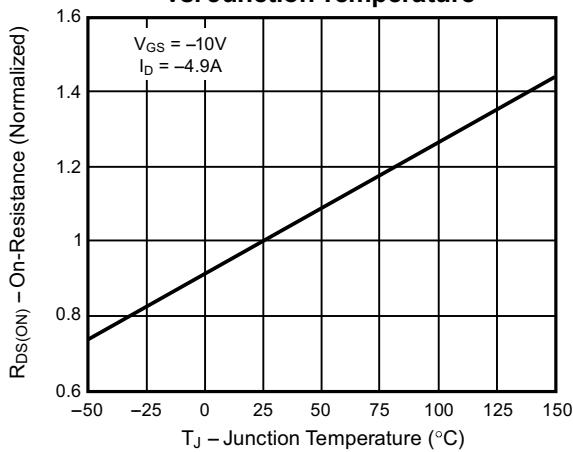
**Fig. 3 – Threshold Voltage vs. Temperature**



**Fig. 4 – On-Resistance vs. Drain Current**



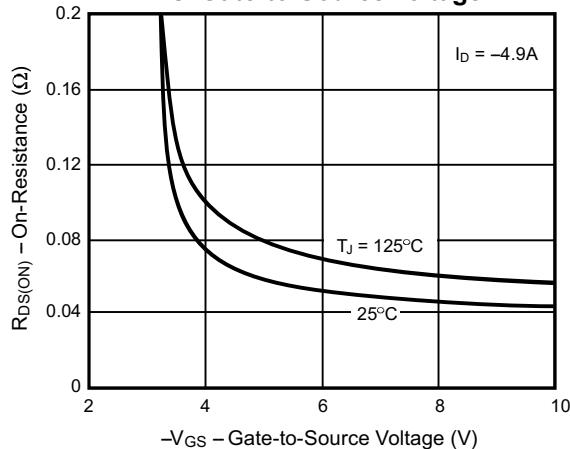
**Fig. 5 – On-Resistance vs. Junction Temperature**



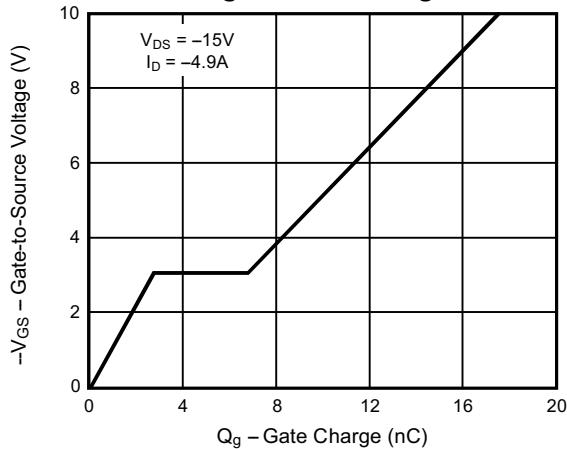
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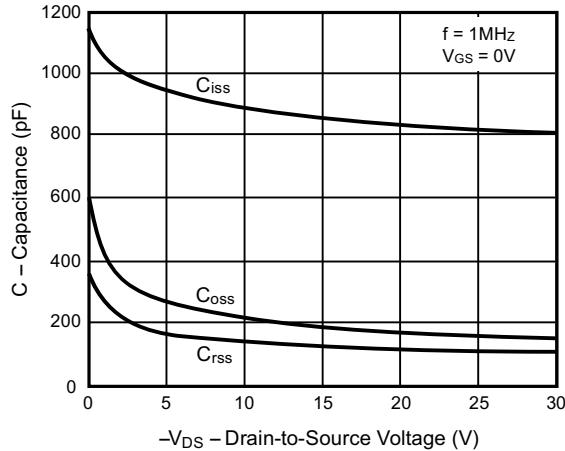
**Fig. 6 – On-Resistance  
vs. Gate-to-Source Voltage**



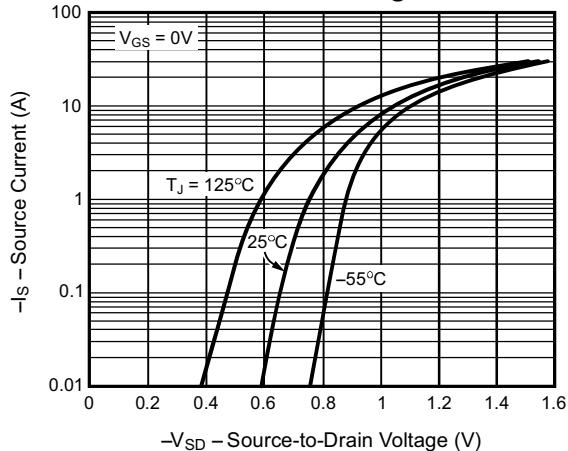
**Fig. 7 – Gate Charge**



**Fig. 8 – Capacitance**



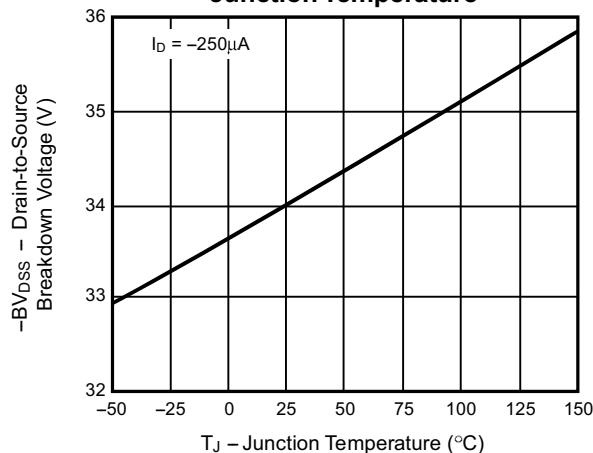
**Fig. 9 – Source-Drain Diode  
Forward Voltage**



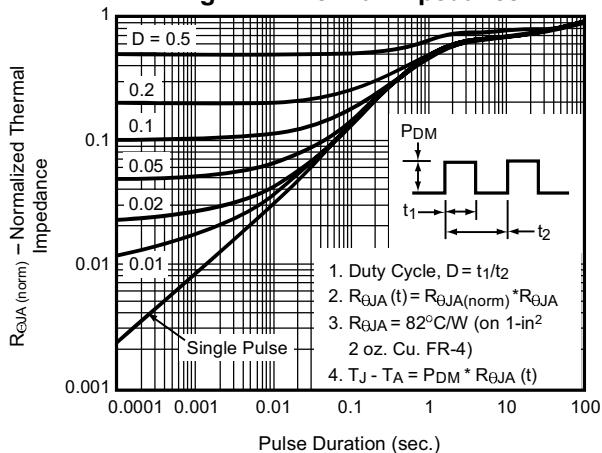
## Dual P-Channel Enhancement-Mode MOSFET

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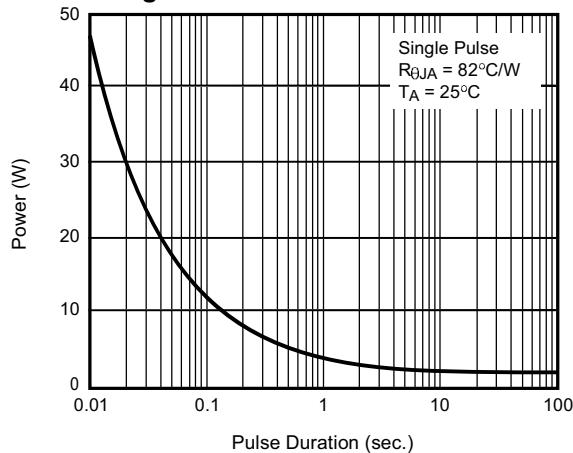
**Fig. 10 – Breakdown Voltage vs.  
Junction Temperature**



**Fig. 11 – Thermal Impedance**



**Fig. 12 – Power vs. Pulse Duration**



**Fig. 13 – Maximum Safe Operating Area**

